National Accreditation Board for Testing and Calibration Laboratories

SCOPE OF ACCREDITATION

Laboratory Name : EMC AND DURABILITY LAB, HCL TECHNOLOGIES LIMITED, 73-74, SOUTH PHASE, AMBATTUR INDUSTRIAL ESTATE, CHENNAI, TAMIL NADU, INDIA

Accreditation Standard ISO/IEC 17025:2017

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S.No	Discipline / Group	Materials or Products tested	Component, parameter or characteristic tested / Specific Test Performed / Tests or type of tests performed	Test Method Specification against which tests are performed and / or the techniques / equipment used
Permanent Facility				
1	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Flicker	ETSI EN301 489-1
2	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Flicker	Withdrawn Standard IEC 61326-1
3	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Magnetic field Immunity test	Withdrawn Standard IEC 61000-6-1
4	ELECTRONICS- EMC TEST FACILITY	Industrial / Medical / Scientific Equipment	Conducted Emission Test (CE)	BS EN 55011:2009+A1
5	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Flicker	IEC 60601-1-2:2014+AMD1
6	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Harmonic Current emission	Withdrawn Standard IEC 61326-1
7	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Magnetic field Immunity test	ETSI EN301 489-1
8	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Magnetic field Immunity test	IEC 60255-26
9	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	EN 61000-4-11
10	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	IEC 60945
11	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	Withdrawn Standard IEC 61326-1
12	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment/ Automotive Equipment/ Aero Equipment/Military Equipment	Radiated Emission Test (RE)	Withdrawn Standard IEC 61000-6-3:2006/AMD1:2010/ISH1
13	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment/ Automotive Equipment/ Aero Equipment/Military Equipment	Radiated Emission Test (RE)	Withdrawn Standard IEC 61000-6-4:2006/AMD1:2010/ISH1
14	ELECTRONICS- EMC TEST FACILITY	Aero Equipment	Conducted Emission Test (CE)	DO 160 G (Section 21)
15	ELECTRONICS- EMC TEST FACILITY	Aero Equipment	Conducted Emission Test (CE)	DO 160 G (Section 21)
16	ELECTRONICS- EMC TEST FACILITY	Aero Equipment	Conducted Emission Test (CE)	DO 160 G (Section 21):2010
17	ELECTRONICS- EMC TEST FACILITY	Aero Products	Power Input	DO 160 G (section 16)

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18	ELECTRONICS- EMC TEST FACILITY	Automation-Marine Equipment	Electrical Fast Transient Test	DNV No 2.4
19	ELECTRONICS- EMC TEST FACILITY	Automation-Marine Equipment	Surge Immunity	DNV No 2.4
20	ELECTRONICS- EMC TEST FACILITY	Automation-Marine Equipment	Conducted RF Susceptibility Test	DNV No 2.4
21	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Electrostatic Discharge Immunity Test (ESD)	ISO 10605:2008/AMD 1:2014
22	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Radiated Emission Test (RE)	UNECE Regulation 10 Revision 6
23	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Radiated Emission Test (RE)	AIS 004
24	ELECTRONICS- EMC TEST FACILITY	Automotive	Bulk Current Injection	ISO 11452-4(ED.3.0) withdrawn
25	ELECTRONICS- EMC TEST FACILITY	Automotive	Bulk Current Injection Test	ISO 11452-4: ED.5.0
26	ELECTRONICS- EMC TEST FACILITY	Automotive	Electrical Fast Transient Test	UNECE Regulation 10 Revision 5
27	ELECTRONICS- EMC TEST FACILITY	Automotive	Electrical Fast Transient Test	UNECE Regulation 10 Revision 6
28	ELECTRONICS- EMC TEST FACILITY	Automotive	Flicker	UNECE Regulation 10 Revision 6
29	ELECTRONICS- EMC TEST FACILITY	Automotive	Flicker Emission Test	UNECE Regulation 10 Revision 5
30	ELECTRONICS- EMC TEST FACILITY	Automotive	Harmonic Current emission	UNECE Regulation 10 Revision 5
31	ELECTRONICS- EMC TEST FACILITY	Automotive	Harmonic Current emission	UNECE Regulation 10 Revision 6
32	ELECTRONICS- EMC TEST FACILITY	Automotive	Surge Immunity	UNECE Regulation 10 Revision 6
33	ELECTRONICS- EMC TEST FACILITY	Automotive	Surge Immunity Test	UNECE Regulation 10 Revision 5
34	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Conducted RF Susceptibility Test	AIS 004
35	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Flicker	AIS 004
36	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Harmonic Current emission	AIS 004

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37	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	RF Radiated Susceptibility Test	AIS 004
38	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Radiated Emission Test (RE)	UNECE Regulation 10 Revision 5
39	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Bulk Current Injection Test	UNECE Regulation 10 Revision 6
40	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Conducted Emission Test (CE)	AIS 004
41	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Conducted Emission Test (CE)	AIS 004
42	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Conducted Emission Test (CE)	CISPR 25
43	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Conducted Emission Test (CE)	ISO 7637-2 (Edition 2 - Transient)
44	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Conducted Emission Test (CE)	Withdrawn Standard CISPR 25
45	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Conducted Emission Test (CE)	AIS004
46	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Conducted Emission Test (CE)	AIS004
47	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Conducted Emission Test (CE)	UNECE Regulation 10 Revision 5
48	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Conducted Emission Test (CE)	UNECE Regulation 10 Revision 6
49	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Conducted Transient Emission Test (CE)	ISO 7637-2
50	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Conducted Transient Emission Test (CE)	UNECE Regulation 10 Revision 5
51	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Conducted Transient Emission Test (CE)	UNECE Regulation 10 Revision 6
52	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Electrostatic Discharge Immunity Test (ESD)	AIS 004
53	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Radiated Emission Test (RE)	AIS 004
54	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Radiated Emission Test (RE)	AIS 004
55	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	Radiated Emission Test (RE)	CISPR 25

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56	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	RF Radiated Susceptibility Test	UNECE Regulation 10 Revision 5
57	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	RF Radiated Susceptibility Test	AIS004
58	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	RF Radiated Susceptibility Test	ISO 11452-2
59	ELECTRONICS- EMC TEST FACILITY	Automotive Equipment	RF Radiated Susceptibility Test	UNECE Regulation 10 Revision 6
60	ELECTRONICS- EMC TEST FACILITY	Commercial	Electrical Fast Transient	IEC 61000-4-4(ED.3.0)
61	ELECTRONICS- EMC TEST FACILITY	Commercial	Electrical Fast Transient Test	EN 61000-4-4(ED.3.0)
62	ELECTRONICS- EMC TEST FACILITY	Commercial	Surge	IEC 61000-4-5(ED.3.0)
63	ELECTRONICS- EMC TEST FACILITY	Commercial	Surge	IEC 61000-4-5:2014+AMD1
64	ELECTRONICS- EMC TEST FACILITY	Commercial	Surge Immunity	BS EN 61000-4-5:2014+A1
65	ELECTRONICS- EMC TEST FACILITY	Commercial	Surge Immunity	BS EN 61000-4-5:2014+A1
66	ELECTRONICS- EMC TEST FACILITY	Conducted Emission Test (CE)	Marine equipment	DNV No 2.4
67	ELECTRONICS- EMC TEST FACILITY	Electrical Power Drive	Conducted RF Susceptibility Test	BS EN IEC 61800-3
68	ELECTRONICS- EMC TEST FACILITY	Electrical Power Drive	Electrical Fast Transient Test	BS EN IEC 61800-3
69	ELECTRONICS- EMC TEST FACILITY	Electrical Power Drive	Electrostatic Discharge Immunity Test (ESD)	BS EN IEC 61800-3
70	ELECTRONICS- EMC TEST FACILITY	Electrical Power Drive	Flicker	BS EN IEC 61800-3
71	ELECTRONICS- EMC TEST FACILITY	Electrical Power Drive	Harmonic Current emission	BS EN IEC 61800-3
72	ELECTRONICS- EMC TEST FACILITY	Electrical Power Drive	Magnetic field Immunity test)	BS EN IEC 61800-3
73	ELECTRONICS- EMC TEST FACILITY	Electrical Power Drive	RF Radiated Susceptibility Test	BS EN IEC 61800-3
74	ELECTRONICS- EMC TEST FACILITY	Electrical Power Drive	Surge Immunity	BS EN IEC 61800-3

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75	ELECTRONICS- EMC TEST FACILITY	Electrical Power Drive	Voltage dips & interrupts Immunity Test (AC & DC)	BS EN IEC 61800-3
76	ELECTRONICS- EMC TEST FACILITY	Electrical Power Drive System	Conducted Emission Test (CE)	BS EN IEC 61800-3
77	ELECTRONICS- EMC TEST FACILITY	Electrical Power Drive System	Radiated Emission Test (RE)	BS EN IEC 61800-3
78	ELECTRONICS- EMC TEST FACILITY	House Hold	Discontinuous conducted Emission	CISPR 14-1(ED.6.0)
79	ELECTRONICS- EMC TEST FACILITY	House Hold	RF Disturbance power	BS EN 55014-1: 2017+A11
80	ELECTRONICS- EMC TEST FACILITY	House Hold	RF Disturbance power	CISPR 14-1
81	ELECTRONICS- EMC TEST FACILITY	House Hold	RF Disturbance power	CISPR 14-1(ED.6.0)
82	ELECTRONICS- EMC TEST FACILITY	House Hold Equipment	Discontinuous conducted Emission	BS EN 55014-1: 2017+A11
83	ELECTRONICS- EMC TEST FACILITY	House Hold Equipments	Discontinuous conducted Emission	CISPR 14-1 (ED.7.0)
84	ELECTRONICS- EMC TEST FACILITY	Household Equipment	Conducted RF Susceptibility Test	CISPR 14-2
85	ELECTRONICS- EMC TEST FACILITY	Household Equipment	RF Radiated Susceptibility Test	CISPR 14-2
86	ELECTRONICS- EMC TEST FACILITY	Household Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	CISPR 14-2
87	ELECTRONICS- EMC TEST FACILITY	Household Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	EN 55014-2
88	ELECTRONICS- EMC TEST FACILITY	Household Equipment	Radiated Emission Test (RE)	BS EN 55014-1: 2017+A11
89	ELECTRONICS- EMC TEST FACILITY	Household	Conducted RF Susceptibility Test	EN 55014-2
90	ELECTRONICS- EMC TEST FACILITY	Household Equipment	Electrical Fast Transient Test	CISPR 14-2
91	ELECTRONICS- EMC TEST FACILITY	Household Equipment	Electrical Fast Transient Test	EN 55014-2
92	ELECTRONICS- EMC TEST FACILITY	Household Equipment	Electrostatic Discharge Immunity Test (ESD)	EN 55014-2
93	ELECTRONICS- EMC TEST FACILITY	Household Equipment	Electrostatic Discharge Immunity Test (ESD)	CISPR 14-2

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94	ELECTRONICS- EMC TEST FACILITY	Household Equipment	Electrostatic Discharge Immunity Test (ESD)	EN 55014-2
95	ELECTRONICS- EMC TEST FACILITY	Household Equipment	Surge Immunity	CISPR 14-2
96	ELECTRONICS- EMC TEST FACILITY	Household Equipment	Surge Immunity	EN 55014-2
97	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic device (IVD)	Harmonic Current emission	Withdrawn Standard EN 61326-2-6
98	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic device (IVD)	Harmonic Current emission	Withdrawn Standard IEC 61326-2-6
99	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic device (IVD)	RF Radiated Susceptibility Test	Withdrawn Standard EN 61326-2-6
100	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic device (IVD)	RF Radiated Susceptibility Test	Withdrawn Standard IEC 61326-2-6
101	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic device (IVD)	Voltage dips & interrupts Immunity Test (AC & DC)	Withdrawn Standard EN 61326-2-6
102	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic device (IVD)	Voltage dips & interrupts Immunity Test (AC & DC)	Withdrawn Standard IEC 61326-2-6
103	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Power Frequency Magnetic field Immunity test	IEC 61326-2-6
104	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Magnetic field Immunity test)	Withdrawn Standard EN 61326-2-6
105	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Magnetic field Immunity test)	Withdrawn Standard IEC 61326-2-6
106	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Conducted RF Susceptibility Test	IEC 61326-2-6
107	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Electrical Fast Transient Test	IEC 61326-2-6
108	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Flicker Emission Test	IEC 61326-2-6
109	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Harmonic Current emission	IEC 61326-2-6
110	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Radiated Emission Test (RE)	Withdrawn Standard IEC 61326-2-6
111	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	RF Radiated Susceptibility Test	IEC 61326-2-6
112	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Surge Immunity Test	IEC 61326-2-6

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113	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Voltage dips & interrupts Immunity Test	IEC 61326-2-6
114	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Radiated Emission Test (RE)	IEC 61326-2-6
115	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Conducted Emission Test	IEC 61326-2-6
116	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Electrical Fast Transient Test	Withdrawn Standard EN 61326-2-6
117	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Electrical Fast Transient Test	Withdrawn Standard IEC 61326-2-6
118	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Electrostatic Discharge Immunity Test (ESD)	IEC 61326-2-6
119	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Electrostatic Discharge Immunity Test (ESD)	Withdrawn Standard EN 61326-2-6
120	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Radiated Emission Test (RE)	Withdrawn Standard EN 61326-2-6
121	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Surge Immunity	Withdrawn Standard EN 61326-2-6
122	ELECTRONICS- EMC TEST FACILITY	In vitro diagnostic medical equipment (IVD)	Surge Immunity	Withdrawn Standard IEC 61326-2-6
123	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Conducted Emission Test (CE)	IEC 61000 6-4
124	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Electrostatic Discharge Immunity Test (ESD)	BS EN IEC 61000 6-1
125	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Electrostatic Discharge Immunity Test (ESD)	BS EN IEC 61000 6-2
126	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Electrostatic Discharge Immunity Test (ESD)	IEC 61000-6-2
127	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	RF Radiated Susceptibility Test	BS EN IEC 61000 6-1
128	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	RF Radiated Susceptibility Test	BS EN IEC 61000 6-2
129	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	RF Radiated Susceptibility Test	IEC 61000-6-1
130	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	RF Radiated Susceptibility Test	IEC 61000-6-2
131	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	BS EN IEC 61000 6-2

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132	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	IEC 61000-6-1
133	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	IEC 61000-6-2
134	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Radiated Emission Test (RE)	IEC 61000 6-4
135	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Radiated Emission Test (RE)	IEC 61000-6-3
136	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Radiated Emission Test (RE)	CISPR 11:2015+AMD1:2016+AMD2
137	ELECTRONICS- EMC TEST FACILITY	Industrial	Damped Oscillatory Immunity Test	IEC 61000-4-18 Ed.2
138	ELECTRONICS- EMC TEST FACILITY	Industrial	Magnetic field Immunity test)	IEC 61000-6-1
139	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Conducted RF Susceptibility Test	IEC 61000-6-2
140	ELECTRONICS- EMC TEST FACILITY	Industrial / Medical / Scientific Equipment	Conducted Emission Test (CE)	BS EN 55011:2016+A11
141	ELECTRONICS- EMC TEST FACILITY	Industrial / Medical / Scientific Equipment	Conducted Emission Test (CE)	CISPR 11:2015+AMD1:2016+AMD2
142	ELECTRONICS- EMC TEST FACILITY	Industrial / Medical / Scientific Equipment	Conducted Emission Test (CE)	IEC 61000-6-3
143	ELECTRONICS- EMC TEST FACILITY	Industrial / Medical / Scientific Equipment	Conducted Emission Test (CE)	BS EN 55011+A11
144	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Conducted Emission test	IEC 61000 6-4
145	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Conducted Emission Test (CE)	IEC 61000-6-4
146	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Conducted Emission Test (CE)	Withdrawn Standard IEC 61000-6-3:2006/AMD1:2010/ISH1
147	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Conducted Emission Test (CE)	Withdrawn Standard IEC 61000-6-4:2006/AMD1:2010/ISH1
148	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Conducted RF Susceptibility Test	Withdrawn Standard IEC 61000-6-1
149	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Conducted RF Susceptibility Test	BS EN IEC 61000 6-1

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150	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Conducted RF Susceptibility Test	BS EN IEC 61000 6-2
151	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Conducted RF Susceptibility Test	IEC 61000-6-1
152	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Conducted RF Susceptibility Test	IEC 61000-6-2
153	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Electrical Fast Transient Test	BS EN IEC 61000-6-1
154	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Electrical Fast Transient Test	BS EN IEC 61000-6-2
155	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Electrical Fast Transient Test	IEC 61000-6-1
156	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Electrical Fast Transient Test	IEC 61000-6-2
157	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Electrostatic Discharge Immunity Test (ESD)	Withdrawn Standard IEC 61000-6-1
158	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Electrostatic Discharge Immunity Test (ESD)	IEC 61000-6-1
159	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Pulse Magnetic Field Immunity Test	IEC 61000 4-9
160	ELECTRONICS- EMC TEST FACILITY	Industrial equipment	Radiated Emission Test (RE)	IEC 61000-6-4
161	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Ring wave Immunity Test	IEC 61000 4-12
162	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Surge Immunity	BS EN IEC 61000-6-1
163	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Surge Immunity	BS EN IEC 61000-6-2
164	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Surge Immunity	IEC 61000-6-1
165	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment	Surge Immunity	IEC 61000-6-2
166	ELECTRONICS- EMC TEST FACILITY	Industrial Equipment (relay)	Radiated Emission Test (RE)	IEC 60255-26
167	ELECTRONICS- EMC TEST FACILITY	Industrial Product	Radiated Emission Test (RE)	BS EN 55011:2016+A2
168	ELECTRONICS- EMC TEST FACILITY	Industrial, Scientific and Medical Equipment	Conducted Emission Test (CE)	CISPR11CISPR 11:2009/AMD1

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169	ELECTRONICS- EMC TEST FACILITY	IndustrialEquipment (UPS)	Radiated Emission Test (RE)	BSEN 62040 - 2
170	ELECTRONICS- EMC TEST FACILITY	Information Technology (IT) Products	Electrical Fast Transient Test	Withdrawn Standard CISPR 24:2010/AMD1
171	ELECTRONICS- EMC TEST FACILITY	IT Equipment	Radiated Emission Test (RE)	FCC Part 15 subpart B
172	ELECTRONICS- EMC TEST FACILITY	IT Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	BS EN 55024:2010+A1:2015
173	ELECTRONICS- EMC TEST FACILITY	IT Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	Withdrawn Standard CISPR 24:2010/AMD1
174	ELECTRONICS- EMC TEST FACILITY	IT Equipment	Conducted Emission Test (CE)	FCC (Part 15 part B & Part 18 part B))
175	ELECTRONICS- EMC TEST FACILITY	IT Equipment	Electrostatic Discharge Immunity Test (ESD)	BS EN 55024:2010+A1:2015
176	ELECTRONICS- EMC TEST FACILITY	IT Equipment	Electrical Fast Transient Test	55024:2010+A1:2015
177	ELECTRONICS- EMC TEST FACILITY	IT Equipment	Electrostatic Discharge Immunity Test (ESD)	Withdrawn Standard CISPR 24
178	ELECTRONICS- EMC TEST FACILITY	IT Equipment	Electrostatic Discharge Immunity Test (ESD	Withdrawn Standard CISPR 24:2010/AMD1
179	ELECTRONICS- EMC TEST FACILITY	IT Equipment	Radiated Emission Test (RE)	BSEN 55022
180	ELECTRONICS- EMC TEST FACILITY	IT Equipment	RF Radiated Susceptibility Test	BS EN 55024:2010+A1
181	ELECTRONICS- EMC TEST FACILITY	IT Equipment	RF Radiated Susceptibility Test	Withdrawn Standard CISPR 24:2010/AMD1
182	ELECTRONICS- EMC TEST FACILITY	IT Equipment	Surge Immunity	Withdrawn Standard CISPR 24:2010/AMD1
183	ELECTRONICS- EMC TEST FACILITY	IT Products	Conducted Emission Test (CE)	BSEN 55022
184	ELECTRONICS- EMC TEST FACILITY	IT Products	Conducted Emission Test (CE)	Withdrawn Standard CISPR22
185	ELECTRONICS- EMC TEST FACILITY	IT Products	Conducted Emission Test (CE)	BS EN 55032
186	ELECTRONICS- EMC TEST FACILITY	IT Products	Conducted Emission Test (CE)	CISPR 32
187	ELECTRONICS- EMC TEST FACILITY	IT Products	Conducted RF Susceptibility Test	CISPR 24

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188	ELECTRONICS- EMC TEST FACILITY	IT Products	Conducted RF Susceptibility Test	BS EN 55024:2010+A1
189	ELECTRONICS- EMC TEST FACILITY	IT Products	Conducted RF Susceptibility Test	Withdrawn Standard CISPR 24:2010/AMD1
190	ELECTRONICS- EMC TEST FACILITY	IT Products	Magnetic field Immunity test)	BS EN 55024:2010+A1:2015
191	ELECTRONICS- EMC TEST FACILITY	IT Products	Magnetic field Immunity test)	Withdrawn Standard CISPR 24:2010/AMD1
192	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	DC Ripple	IEC 61000-4-17:1999+AMD1:2001 +AMD2
193	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Flicker	IEC 61000-3-11
194	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Flicker	BS EN 61000-3-3:2013+A1:2019
195	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Flicker	IEC 61000-3-3:2013/AMD1:2017
196	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Harmonic Current emission	BS EN IEC 61000-3-12
197	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Harmonic Current emission	BS EN IEC 61000-3-2
198	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Harmonic Current emission	IEC 61000-3-12
199	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Harmonic Current emission	IEC 61000-3-2:2018/AMD1:2020
200	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Harmonic Current emission	IEC 61000-3-2:2018/AMD1:2020
201	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Harmonics and Interharmonics	BS EN 61000-4-13:2002+A2
202	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Magnetic field Immunity test)	BS EN IEC 61000 6-2
203	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Magnetic field Immunity test)	IEC 61000-6-2
204	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	BS EN IEC 61000-4-11
205	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	BS EN IEC 61000-4-34

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206	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	IEC 61000-4-11
207	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	IEC 61000-4-34
208	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial	DC Ripple	IEC 61000-4-17
209	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial	Harmonics & Interharmonics	IEC 61000-4-13
210	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Flicker	EN 61000-3-3
211	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Flicker	ETSI EN 300 386
212	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Flicker	ETSI EN301 489-1
213	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Flicker	IEC 61000-3-3:2013+AMD1:2017+ AMD2
214	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Flicker	IEC 61000-3-3:2013+AMD1:2017+ AMD2
215	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Harmonic Current emission	EN IEC 61000-3-2:2019/A1
216	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Harmonic Current emission	ETSI EN 300 386
217	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Harmonic Current emission	ETSI EN301 489-1
218	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Harmonic Current emission	IEC 60601-1-2:2014+AMD1
219	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Harmonic Current emission	IEC 61000-3-12:2011+AMD1
220	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Harmonic Current emission	IEC 61000-3-2:2018+AMD1
221	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Harmonic Current emission	IEC 61496-1
222	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Magnetic field Immunity test	BS EN 55024:2010+A1
223	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Magnetic field Immunity test	BSEN 62040-2

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224	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Magnetic field Immunity test	EN 61000-4-8
225	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Magnetic field Immunity test	ETSI EN 300 386
226	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Magnetic field Immunity test	IEC 60601-1-2:2014+AMD1
227	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Magnetic field Immunity test	IEC 61000-4-8
228	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Magnetic field Immunity test	IEC 61000-4-8
229	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Magnetic field Immunity test	Withdrawn Standard CISPR 24
230	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical	Magnetic field Immunity test	Withdrawn Standard IEC 61000-6-2
231	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	IEC 61000-4-11
232	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	BS EN 60601-1-2:2015+A1
233	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	BSEN 55024
234	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	EN 55014-2
235	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	ETSI EN 300 386
236	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	IEC 60601-1-2:2014+AMD1
237	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	IEC 60945
238	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	IEC 61000-4-29
239	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	IEC 61000-6-2 withdrawn
240	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	Withdrawn Standard CISPR 24
241	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	Withdrawn Standard IEC 61000-6-1
242	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	Withdrawn Standard IEC 61326-1

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243	ELECTRONICS- EMC TEST FACILITY	IT Products / Household / Industrial / Medical / Marine Equipment	Voltage dips, short interruption & voltage variations Immunity Test	IEC 61326-1
244	ELECTRONICS- EMC TEST FACILITY	IT Products Equipment	Conducted RF Susceptibility Test	BSEN 55024
245	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical	Electrical Fast Transient Test	EN IEC 55014-2
246	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical	Flicker	IEC 61000-6-3
247	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical	Flicker	IEC 61000-6-4
248	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical	Harmonic Current emission	BS EN 61000-3-3:2013+A2
249	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical	Harmonic Current emission	ETSI EN301 489-1
250	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical	Harmonic Current emission	IEC 61000-6-3
251	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical	Harmonic Current emission	IEC 61000-6-4
252	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical	Magnetic field Immunity test	EN IEC 55014-2
253	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical	Surge Immunity	EN IEC 55014-2
254	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Marine Equipment	Conducted RF Susceptibility Test	EN IEC 55014-2
255	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Marine Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	ENIEC 55014-2
256	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Aero Equipment/ Auto Equipment/ Marine Equipment	Electrostatic Discharge Immunity Test (ESD)	EN IEC 55014-2
257	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	EN IEC 55014-2
258	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	GR1089 :Issue 6
259	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical / Marine Equipment	Conducted RF Susceptibility Test	EN 61000-4-6
260	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical / Marine Equipment	Conducted RF Susceptibility Test	IEC 61000-4-6

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261	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Aero Equipment/ Auto Equipment/Marine Equipment	Electrostatic Discharge Immunity Test (ESD)	IEC 61000-4-2
262	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Aero Equipment/ Auto Equipment/Marine Equipment	Electrostatic Discharge Immunity Test (ESD)	BSEN 55024
263	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Aero Equipment/ Auto Equipment/Marine Equipment	Electrostatic Discharge Immunity Test (ESD)	DNV No 2.4
264	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Aero Equipment/ Auto Equipment/Marine Equipment	Electrostatic Discharge Immunity Test (ESD)	DO 160 G (section 25)
265	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Aero Equipment/ Auto Equipment/Marine Equipment	Electrostatic Discharge Immunity Test (ESD)	EN 61000-4-2
266	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Aero Equipment/ Auto Equipment/Marine Equipment	Electrostatic Discharge Immunity Test (ESD)	ETSI EN301 489-1
267	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Aero Equipment/ Auto Equipment/Marine Equipment	Electrostatic Discharge Immunity Test (ESD)	IEEE C37.90.3
268	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Aero Equipment/ Auto Equipment/Marine Equipment	Electrostatic Discharge Immunity Test (ESD)	ISO 10605:2008/AMD 1
269	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Aero Equipment/ Auto Equipment/Marine Equipment	Electrostatic Discharge Immunity Test (ESD)	Withdrawn Standard IEC 61000-6-2
270	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Aero Equipment/ Auto Equipment/Marine Equipment	Electrostatic Discharge Immunity Test (ESD)	Withdrawn Standard IEC 61326-2-6
271	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	BS EN 55024:2010+A1
272	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	BS EN 60601-1-2:2015+A1
273	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	BS EN 61000-4-3:2006+A2
274	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	BSEN 62040-2
275	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	EN 55014-2

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276	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	ETSI EN301 489-1
277	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	IEC 60601-1-2:2014+AMD1
278	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	IEC 61000-4-3
279	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	IEC 61000-6-2 withdrawn
280	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	IEC 61326-1
281	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	IEEE C37.90.2
282	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	Withdrawn Standard CISPR 24
283	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment	RF Radiated Susceptibility Test	Withdrawn Standard IEC 61000-6-1
284	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment/ Automotive Equipment/ Aero Equipment/Military Equipment	Conducted Emission Test (CE)	FCC (Part 15)
285	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment/ Automotive Equipment/ Aero Equipment/Military Equipment	Conducted Emission Test (CE)	GR1089 :Issue 6
286	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment/ Automotive Equipment/ Aero Equipment/Military Equipment	Electrostatic Discharge Immunity Test (ESD)	GR1089 :Issue 6
287	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment/ Automotive Equipment/ Aero Equipment/Military Equipment	Radiated Emission Test (RE)	DO 160 G (Section 21)
288	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment/ Automotive Equipment/ Aero Equipment/Military Equipment	Radiated Emission Test (RE)	FCC (Part 15)
289	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment/ Automotive Equipment/ Aero Equipment/Military Equipment	Radiated Emission Test (RE)	MIL 461 E (RE101)
290	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment/ Automotive Equipment/ Aero Equipment/Military Equipment	Radiated Emission Test (RE)	MIL 461 F (RE101)
291	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment/ Automotive Equipment/ Aero Equipment/Military Equipment	Radiated Emission Test (RE)	MIL 461 F (RE102)

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292	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment/ Automotive Equipment/ Aero Equipment/Military Equipment	Radiated Emission Test (RE)	Withdrawn Standard CISPR 11:2009/AMD1
293	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment/ Automotive Equipment/ Aero Equipment/Military Equipment	Radiated Emission Test (RE)	Withdrawn Standard CISPR 25
294	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment/ Automotive Equipment/ Aero Equipment/Military Equipment	Radiated Emission Test (RE)	Withdrawn Standard CISPR22
295	ELECTRONICS- EMC TEST FACILITY	IT Products/ Household/ Industrial/ Medical/ Network Telecommunications Equipment/ Marine Equipment/ Automotive Equipment/ Aero Equipment/Military Equipment	Radiated Emission Test (RE)	Withdrawn Standard IEC 61326-1
296	ELECTRONICS- EMC TEST FACILITY	IT Products/ Measurement, Control & Laboratory products	RF Radiated Susceptibility Test	Withdrawn Standard EN 61326-1
297	ELECTRONICS- EMC TEST FACILITY	Laboratory Equipment	Radiated Emission Test (RE)	Withdrawn Standard EN 61326-1
298	ELECTRONICS- EMC TEST FACILITY	Laboratory Equipment	Radiated Emission Test (RE)	Withdrawn Standard IEC 61326-1
299	ELECTRONICS- EMC TEST FACILITY	Laboratory Equipment	Radiated Emission Test (RE)	IEC 61326-1
300	ELECTRONICS- EMC TEST FACILITY	Lifts & Escalator	Conducted Emission Test (CE)	BS EN 12015
301	ELECTRONICS- EMC TEST FACILITY	Lifts & Escalator	Conducted RF Susceptibility Test	EN 12016
302	ELECTRONICS- EMC TEST FACILITY	Lifts & Escalator	Electrical Fast Transient Test	EN 12016
303	ELECTRONICS- EMC TEST FACILITY	Lifts & Escalator	Electrostatic Discharge Immunity Test (ESD)	EN 12016
304	ELECTRONICS- EMC TEST FACILITY	Lifts & Escalator	Magnetic field Immunity test)	EN 12016
305	ELECTRONICS- EMC TEST FACILITY	Lifts & Escalator	Radiated Emission Test (RE)	BS EN 12015
306	ELECTRONICS- EMC TEST FACILITY	Lifts & Escalator	RF Radiated Susceptibility Test	EN 12016
307	ELECTRONICS- EMC TEST FACILITY	Lifts & Escalator	Surge Immunity	EN 12016
308	ELECTRONICS- EMC TEST FACILITY	Lifts & Escalator	Voltage dips & interrupts Immunity Test (AC & DC)	EN 12016

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309	ELECTRONICS- EMC TEST FACILITY	Lighting Equipment	Conducted Emission Test (CE)	BS EN IEC 55015:2019+A11
310	ELECTRONICS- EMC TEST FACILITY	Lighting Equipment	Conducted Emission Test (CE)	CISPR15
311	ELECTRONICS- EMC TEST FACILITY	Lighting Equipment	Conducted RF Susceptibility Test	IEC 61547
312	ELECTRONICS- EMC TEST FACILITY	Lighting Equipment	Electrical Fast Transient Test	IEC 61547
313	ELECTRONICS- EMC TEST FACILITY	Lighting Equipment	Electrostatic Discharge Immunity Test (ESD)	IEC 61547
314	ELECTRONICS- EMC TEST FACILITY	Lighting Equipment	Magnetic field Immunity test)	IEC 61547
315	ELECTRONICS- EMC TEST FACILITY	Lighting Equipment	Radiated Emission Test (RE)	BS EN IEC 55015:2019+A11
316	ELECTRONICS- EMC TEST FACILITY	Lighting Equipment	Radiated Emission Test (RE)	CISPR 15
317	ELECTRONICS- EMC TEST FACILITY	Lighting Equipment	RF Radiated Susceptibility Test	IEC 61547
318	ELECTRONICS- EMC TEST FACILITY	Lighting Equipment	Surge Immunity	IEC 61547
319	ELECTRONICS- EMC TEST FACILITY	Lighting Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	IEC 61547
320	ELECTRONICS- EMC TEST FACILITY	Machinery	Electrostatic Discharge Immunity Test (ESD)	IEC 61496-1 edition 4.0
321	ELECTRONICS- EMC TEST FACILITY	Marine Equipment	RF Radiated Susceptibility Test	DNV No 2.4
322	ELECTRONICS- EMC TEST FACILITY	Marine Equipment	Conducted RF Susceptibility Test	IEC 60945
323	ELECTRONICS- EMC TEST FACILITY	Marine Equipment	Electrical Fast Transient Test	IEC 60945
324	ELECTRONICS- EMC TEST FACILITY	Marine Equipment	Electrostatic Discharge Immunity Test (ESD)	IEC 60945
325	ELECTRONICS- EMC TEST FACILITY	Marine Equipment	Radiated Emission Test (RE)	IEC 60945
326	ELECTRONICS- EMC TEST FACILITY	Marine Equipment	Surge Immunity	IEC 60945
327	ELECTRONICS- EMC TEST FACILITY	Maritime navigation & radio communication Equipment	Conducted Emission Test (CE)	IEC 60945

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328	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Conducted Emission Test (CE)	IEC 61326-1
329	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Conducted Emission Test (CE)	BS EN 61326-1
330	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Conducted RF Susceptibility Test	Withdrawn Standard EN 61326-1
331	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Conducted RF Susceptibility Test	Withdrawn Standard IEC 61326-1
332	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Electrical Fast Transient Test	Withdrawn Standard EN 61326-1
333	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Electrical Fast Transient Test	Withdrawn Standard IEC 61326-1
334	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Flicker	EN 61326-2
335	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Magnetic field Immunity test)	Withdrawn Standard EN 61326-1
336	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Magnetic field Immunity test)	Withdrawn Standard IEC 61326-1
337	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Surge Immunity	Withdrawn Standard EN 61326-1
338	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Surge Immunity	Withdrawn Standard IEC 61326-1
339	ELECTRONICS- EMC TEST FACILITY	Measurement, Control and laboratory - Diagnostic	Conducted Emission Test (CE)	IEC 61326-2-6
340	ELECTRONICS- EMC TEST FACILITY	Measurement, Control and laboratory - Diagnostic	Conducted Emission Test (CE)	BS EN 61326-2-6
341	ELECTRONICS- EMC TEST FACILITY	Measurement, Control and laboratory - Diagnostic	Electrostatic Discharge Immunity Test (ESD)	Withdrawn Standard EN 61326-1
342	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Conducted Emission Test (CE)	Withdrawn Standard IEC 61326-1
343	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Conducted RF Susceptibility Test	IEC 61326-1
344	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Conducted RF Susceptibility Test	Withdrawn Standard IEC 61326-1
345	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Electrical Fast Transient Test	IEC 61326-1
346	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Magnetic field Immunity test	IEC 61326-1

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347	ELECTRONICS- EMC TEST FACILITY	Measurement, Control & Laboratory products	Surge Immunity	IEC 61326-1
348	ELECTRONICS- EMC TEST FACILITY	Measurement, Control and laboratory - Diagnostic	Conducted Emission Test (CE)	Withdrawn Standard IEC 61326-2-6
349	ELECTRONICS- EMC TEST FACILITY	Measurement, Control and laboratory - Diagnostic	Electrostatic Discharge Immunity Test (ESD)	IEC 61326-1
350	ELECTRONICS- EMC TEST FACILITY	Measurement, Control and laboratory - Diagnostic	Electrostatic Discharge Immunity Test (ESD)	Withdrawn Standard IEC 61326-1
351	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Flicker	BS EN 60601-1-2:2015+A1
352	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	RF Radiated Susceptibility Test	IEC 60601-1-2:2014+AMD1
353	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	IEC 60601-1-2:2014+AMD1
354	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Radiated Emission Test (RE)	BS EN 60601-1-2:2015+A1
355	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Harmonic Current emission	BS EN 60601-1-2:2015+A1
356	ELECTRONICS- EMC TEST FACILITY	Medical	Conducted Emission Test (CE)	IEC 60601-1-2:2014+AMD1
357	ELECTRONICS- EMC TEST FACILITY	Medical /Scientific /Industrial Equipment	Radiated Emission Test (RE)	BS EN 55011+A11
358	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Conducted Emission Test (CE)	BS EN 60601-1-2:2015+A1
359	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Conducted RF Susceptibility Test	BS EN 60601-1-2:2015+A1
360	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Conducted RF Susceptibility Test	IEC 60601-1-2:2014+AMD1
361	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Conducted RF Susceptibility Test	Withdrawn Standard EN 61326-2-6
362	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Conducted RF Susceptibility Test	Withdrawn Standard IEC 61326-2-6
363	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Electrical Fast Transient Test	IEC 60601-1-2:2014+AMD1
364	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Electrical Fast Transient Test	BS EN 60601-1-2:2015+A1
365	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Electrostatic Discharge Immunity Test (ESD)	BS EN 60601-1-2:2015+A1

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366	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Electrostatic Discharge Immunity Test (ESD)	IEC 60601-1-2:2014+AMD1
367	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Magnetic field Immunity test)	BS EN 60601-1-2:2015+A1
368	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Radiated Emission Test (RE)	IEC 60601-1-2:2014+AMD1
369	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Surge Immunity	BS EN 55024:2010+A1:2015
370	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Surge Immunity	IEC 60601-1-2:2014+AMD1
371	ELECTRONICS- EMC TEST FACILITY	Medical Equipment	Surge Immunity Test	BS EN 60601-1-2:2015+A1
372	ELECTRONICS- EMC TEST FACILITY	MIL Products	Power Input	MIL 704 A,B,C,F
373	ELECTRONICS- EMC TEST FACILITY	Military Equipment	Radiated Emission Test (RE)	MIL 461 G (RE101)
374	ELECTRONICS- EMC TEST FACILITY	Military Equipment	Conducted Emission Test (CE)	MIL 461 E (CE101 & CE102)
375	ELECTRONICS- EMC TEST FACILITY	Military Equipment	Conducted Emission Test (CE)	MIL 461 F (CE101 & CE102)
376	ELECTRONICS- EMC TEST FACILITY	Military Equipment	Conducted susceptibility (CS114)	461 E
377	ELECTRONICS- EMC TEST FACILITY	Military Equipment	Conducted Susceptibility Test (CS114)	461 F
378	ELECTRONICS- EMC TEST FACILITY	Military Equipment	Conducted Susceptibility Test (CS114)	461 G
379	ELECTRONICS- EMC TEST FACILITY	Military Equipment	Radiated Emission Test (RE)	MIL 461 E (RE 102)
380	ELECTRONICS- EMC TEST FACILITY	Military Products	Electrostatic Discharge Immunity Test-CS118	MIL 461 G
381	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Radiated Emission Test (RE)	BS EN 55032:2015+A11
382	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Radiated Emission Test (RE)	CISPR 32:2015/AMD1
383	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Conducted Emission Test (CE)	CISPR 32
384	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Conducted Emission Test (CE)	EN55032

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385	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Conducted Emission Test (CE)	BS EN 55032:2015+A11
386	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Conducted Emission Test (CE)	CISPR 32:2015/AMD1:2019
387	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Conducted RF Susceptibility Test	BS EN 55035:2017+A11
388	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Conducted RF Susceptibility Test	CISPR 35
389	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Electrical Fast Transient Test	BS EN 55035:2017+A11
390	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Electrical Fast Transient Test	CISPR 35
391	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Electrostatic Discharge Immunity Test (ESD)	BS EN 55035:2017+A11
392	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Electrostatic Discharge Immunity Test (ESD)	CISPR 35
393	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Magnetic field Immunity test)	BS EN 55035:2017+A11
394	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Magnetic field Immunity test)	CISPR 35
395	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Radiated Emission Test (RE)	CISPR 32
396	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	RF Radiated Susceptibility Test	BS EN 55035:2017+A11
397	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	RF Radiated Susceptibility Test	CISPR 35
398	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Surge Immunity	BS EN 55035:2017+A11
399	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Surge Immunity	CISPR 35
400	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	BS EN 55035:2017+A11
401	ELECTRONICS- EMC TEST FACILITY	Multimedia Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	CISPR 35
402	ELECTRONICS- EMC TEST FACILITY	Power station and substation environment	DC Ripple	BS EN 61000 6-5
403	ELECTRONICS- EMC TEST FACILITY	Power station and substation environment	Conducted RF Susceptibility Test	BS EN 61000 6-5

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404	ELECTRONICS- EMC TEST FACILITY	Power station and substation environment	Conducted RF Susceptibility Test	IEC 61000 6-5
405	ELECTRONICS- EMC TEST FACILITY	Power station and substation environment	DC Ripple	IEC 61000 6-5
406	ELECTRONICS- EMC TEST FACILITY	Power station and substation environment	Electrical Fast Transient Test	BS EN 61000 6-5
407	ELECTRONICS- EMC TEST FACILITY	Power station and substation environment	Electrical Fast Transient Test	IEC 61000 6-5
408	ELECTRONICS- EMC TEST FACILITY	Power station and substation environment	Electrostatic Discharge Immunity Test (ESD)	BS EN 61000 6-5
409	ELECTRONICS- EMC TEST FACILITY	Power station and substation environment	Electrostatic Discharge Immunity Test (ESD)	IEC 61000 6-5
410	ELECTRONICS- EMC TEST FACILITY	Power station and substation environment	Magnetic field Immunity test)	BS EN 61000 6-5
411	ELECTRONICS- EMC TEST FACILITY	Power station and substation environment	Magnetic field Immunity test)	IEC 61000 6-5
412	ELECTRONICS- EMC TEST FACILITY	Power station and substation environment	RF Radiated Susceptibility Test	IEC 61000 6-5
413	ELECTRONICS- EMC TEST FACILITY	Power station and substation environment	RF Radiated Susceptibility Test)	BS EN 61000 6-5
414	ELECTRONICS- EMC TEST FACILITY	Power station and substation environment	Surge Immunity	BS EN 61000 6-5
415	ELECTRONICS- EMC TEST FACILITY	Power station and substation environment	Surge Immunity	IEC 61000 6-5
416	ELECTRONICS- EMC TEST FACILITY	Power station and substation environment	Voltage dips & interrupts Immunity Test (AC & DC)	BS EN 61000 6-5
417	ELECTRONICS- EMC TEST FACILITY	Power station and substation environment	Voltage dips & interrupts Immunity Test (AC & DC)	IEC 61000 6-5
418	ELECTRONICS- EMC TEST FACILITY	Radio Equipment	Conducted Emission Test (CE)	ETSI EN 301 489-1
419	ELECTRONICS- EMC TEST FACILITY	Radio Equipment	Conducted RF Susceptibility Test	ETSI EN 301 489-1
420	ELECTRONICS- EMC TEST FACILITY	Radio Equipment	Electrical Fast Transient Test	ETSI EN 301 489-1
421	ELECTRONICS- EMC TEST FACILITY	Radio Equipment	Electrostatic Discharge Immunity Test (ESD)	ETSI EN 301 489-1
422	ELECTRONICS- EMC TEST FACILITY	Radio Equipment	RF Radiated Susceptibility Test	ETSI EN 301 489-1

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423	ELECTRONICS- EMC TEST FACILITY	Radio Equipment	Surge Immunity	ETSI EN 301 489-1
424	ELECTRONICS- EMC TEST FACILITY	Radio Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	ETSI EN 301 489-1
425	ELECTRONICS- EMC TEST FACILITY	Radio Equipment	Radiated Emission Test (RE)	ETSI EN 301 489-1
426	ELECTRONICS- EMC TEST FACILITY	Radio Equipment	Harmonic Current emission	ETSI EN 301 489-1
427	ELECTRONICS- EMC TEST FACILITY	Radio Equipment	Magnetic field Immunity test)	ETSI EN 301 489-1
428	ELECTRONICS- EMC TEST FACILITY	Radio Equipment	Flicker	ETSI EN 301 489-1
429	ELECTRONICS- EMC TEST FACILITY	Radio Equipment and Ancillary Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	ETSI EN301 489-1
430	ELECTRONICS- EMC TEST FACILITY	Relay Protection Equipment	Electrical Fast Transient Test	IEC 60255-26
431	ELECTRONICS- EMC TEST FACILITY	Relay Protection Equipment	RF Radiated Susceptibility Test	IEC 60255-26
432	ELECTRONICS- EMC TEST FACILITY	Relay Protection Equipment	Surge Immunity	IEC 60255-26
433	ELECTRONICS- EMC TEST FACILITY	Relay Protection Equipment	Conducted RF Susceptibility Test	IEC 60255-26
434	ELECTRONICS- EMC TEST FACILITY	Relay Protection Equipment	Electrostatic Discharge Immunity Test (ESD)	IEC 60255-26
435	ELECTRONICS- EMC TEST FACILITY	Relay Protection Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	IEC 60255-26
436	ELECTRONICS- EMC TEST FACILITY	Relay, Protection Equipment	Conducted Emission Test (CE)	IEC 60255-26
437	ELECTRONICS- EMC TEST FACILITY	RF wireless	Radiated Spurious Emission	EN 301 893 - V2.1.1
438	ELECTRONICS- EMC TEST FACILITY	RF wireless	Radiated Spurious Emission	ETSI EN 300 328 V2.1.1
439	ELECTRONICS- EMC TEST FACILITY	RF wireless	Radiated Spurious Emission	FCC Part 15 subpart C & Part 18 subpart C
440	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Apparatus	Conducted Emission Test (CE)	BS EN 50121-3-2:2016+A1
441	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Apparatus	Conducted RF Susceptibility Test	BS EN 50121-3-2:2016+A1:2019

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442	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Apparatus	Electrical Fast Transient Test	BS EN 50121-3-2:2016+A1:2019
443	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Apparatus	Electrostatic Discharge Immunity Test (ESD)	BS EN 50121-3-2:2016+A1:2019
444	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Apparatus	Magnetic field Immunity test)	BS EN 50121-3-2:2016+A1:2019
445	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Apparatus	RF Radiated Susceptibility Test)	BS EN 50121-3-2:2016+A1
446	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Apparatus	Surge Immunity	BS EN 50121-3-2:2016+A1
447	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Apparatus	Voltage dips & interrupts Immunity Test (AC & DC)	BS EN 50121-3-2:2016+A1:2019
448	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Signaling and Telecommunction Apparatus	Electrical Fast Transient Test	BS EN 50121-5:2017+A1
449	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Signaling and Telecommunication Apparatus	Conducted Emission Test (CE)	BS EN 50121-5:2017+A1
450	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Signaling and Telecommunication Apparatus	Conducted RF Susceptibility Test	BS EN 50121-5:2017+A1
451	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Signaling and Telecommunication Apparatus	Electrostatic Discharge Immunity Test (ESD	BS EN 50121-5:2017+A1
452	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Signaling and Telecommunication Apparatus	Magnetic field Immunity test)	BS EN 50121-5:2017+A1
453	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Signaling and Telecommunication Apparatus	RF Radiated Susceptibility Test)	BS EN 50121-5:2017+A1
454	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Signaling and Telecommunication Apparatus	Surge Immunity	BS EN 50121-5:2017+A1
455	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Signaling and Telecommunication Apparatus	Voltage dips & interrupts Immunity Test (AC & DC)	BS EN 50121-5:2017+A1
456	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Apparatus	Radiated Emission Test (RE)	BS EN 50121-3-2:2016+A1:2019
457	ELECTRONICS- EMC TEST FACILITY	Rolling Stock Signaling and Telecommunication Apparatus	Radiated Emission Test (RE)	BS EN 50121-5:2017+A1
458	ELECTRONICS- EMC TEST FACILITY	Safety Machinery	Conducted RF Susceptibility Test	IEC 61496-1
459	ELECTRONICS- EMC TEST FACILITY	Safety Machinery	Electrical Fast Transient Test	IEC 61496-1,edition 4.0
460	ELECTRONICS- EMC TEST FACILITY	Safety Machinery	Magnetic field Immunity test)	IEC 61496-1 edition 4.0

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461	ELECTRONICS- EMC TEST FACILITY	Safety Machinery	RF Radiated Susceptibility Test	IEC 61496-1 edition 4.0
462	ELECTRONICS- EMC TEST FACILITY	Safety Machinery	Surge Immunity	IEC 61496-1 edition 4.0
463	ELECTRONICS- EMC TEST FACILITY	Telecom Equipment	Electrostatic Discharge Immunity Test (ESD)	GR1089:Issue 7
464	ELECTRONICS- EMC TEST FACILITY	Telecom Equipment	Conducted RF Susceptibility Test	GR1089:Issue 7
465	ELECTRONICS- EMC TEST FACILITY	Telecom Equipment	Electrostatic Discharge Immunity Test (ESD)	GR089 Issue7
466	ELECTRONICS- EMC TEST FACILITY	Telecom Equipment	Radiated Emission Test (RE)	ETSI EN 300 386
467	ELECTRONICS- EMC TEST FACILITY	Telecom Equipment	Radiated Emission Test (RE)	ETSI EN301 489-1
468	ELECTRONICS- EMC TEST FACILITY	Telecom Equipment	Radiated Emission Test (RE)	ETSI EN301 489-1
469	ELECTRONICS- EMC TEST FACILITY	Telecom Equipment	Radiated Emission Test (RE)	GR1089 :Issue 6
470	ELECTRONICS- EMC TEST FACILITY	Telecom Equipment	RF Radiated Susceptibility Test	GR1089 Issue 7
471	ELECTRONICS- EMC TEST FACILITY	Telecom Equipment	Surge Immunity	GR1089 Issue 7
472	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Conducted Emission Test (CE)	ETSI EN 300 386 V2.1.0
473	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Conducted RF Susceptibility Test	ETSI EN 300 386 V2.1.0
474	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Electrical Fast Transient Test	ETSI EN 300 386 V2.1.0
475	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	RF Radiated Susceptibility Test	ETSI EN 300 386 V2.1.0
476	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Surge Immunity	ETSI EN 300 386 V2.1.0
477	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	ETSI EN 300 386 V2.1.0
478	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Radiated Emission Test (RE)	ETSI EN 300 386 V2.1.0
479	ELECTRONICS- EMC TEST FACILITY	Telecommunication	Conducted Emission Test (CE)	TEC/SD/DD/EMC-221/05/OCT

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480	ELECTRONICS- EMC TEST FACILITY	Telecommunication	Conducted RF Susceptibility Test	TEC/SD/DD/EMC-221/05/OCT
481	ELECTRONICS- EMC TEST FACILITY	Telecommunication	Electrical Fast Transient Test	TEC release 6 Oct 2016
482	ELECTRONICS- EMC TEST FACILITY	Telecommunication	Electrical Fast Transient Test	TEC/SD/DD/EMC-221/05/OCT
483	ELECTRONICS- EMC TEST FACILITY	Telecommunication	Electrostatic Discharge Immunity Test (ESD)	TEC/SD/DD/EMC-221/05/OCT
484	ELECTRONICS- EMC TEST FACILITY	Telecommunication	Magnetic field Immunity test)	TEC/SD/DD/EMC-221/05/OCT
485	ELECTRONICS- EMC TEST FACILITY	Telecommunication	Radiated Emission Test (RE)	TEC/SD/DD/EMC-221/05/OCT
486	ELECTRONICS- EMC TEST FACILITY	Telecommunication	RF Radiated Susceptibility Test)	TEC release 6 Oct 2016
487	ELECTRONICS- EMC TEST FACILITY	Telecommunication	Surge Immunity	TEC/SD/DD/EMC-221/05/OCT
488	ELECTRONICS- EMC TEST FACILITY	Telecommunication	Voltage dips & interrupts Immunity Test (AC & DC)	TEC/SD/DD/EMC-221/05/OCT
489	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Electrical Fast Transient Test	GR1089 Issue7
490	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Conducted Emission Test (CE)	ETSI EN 300 386
491	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Conducted Emission Test (CE)	ETSI EN 300 386
492	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Conducted RF Susceptibility Test	ETSI EN 300 386
493	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Conducted RF Susceptibility Test	ETSI EN 300 386
494	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Electrical Fast Transient Test	ETSI EN 300 386
495	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Flicker	ETSI EN 300 386
496	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Flicker	ETSI EN 300 386 V2.1.0
497	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Harmonic Current emission	ETSI EN 300 386
498	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Harmonic Current emission	ETSI EN 300 386

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499	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Harmonic Current emission	ETSI EN 300 386 V2.1.0
500	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Harmonics Current Emission	ETSI EN 301 489-1
501	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Magnetic field Immunity test	ETSI EN 300 386
502	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Magnetic field Immunity test)	ETSI EN 300 386 V2.1.0
503	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Radiated Emission Test (RE)	ETSI EN 300 386
504	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	RF Radiated Susceptibility Test	ETSI EN 300 386
505	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Surge Immunity	ETSI EN 300 386
506	ELECTRONICS- EMC TEST FACILITY	Telecommunication Equipment	Voltage dips & interrupts Immunity Test (AC & DC)	ETSI EN 300 386
507	ELECTRONICS- EMC TEST FACILITY	Telecommunications Equipment	Electrostatic Discharge Immunity Test (ESD)	ETSI EN 300 386 V2.1.0
508	ELECTRONICS- EMC TEST FACILITY	Telecommunications Equipment	Conducted Emission Test (CE)	ETSI EN301 489-1
509	ELECTRONICS- EMC TEST FACILITY	Telecommunications Equipment	Conducted Emission Test (CE)	ETSI EN301 489-1
510	ELECTRONICS- EMC TEST FACILITY	Telecommunications Equipment	Conducted Emission Test (CE)	GR1089 (Issue 6)
511	ELECTRONICS- EMC TEST FACILITY	Telecommunications Equipment	Electrostatic Discharge Immunity Test (ESD)	ETSI EN 300 386
512	ELECTRONICS- EMC TEST FACILITY	Telecommunications Equipment	Electrostatic Discharge Immunity Test (ESD)	ETSI EN 300 386
513	ELECTRONICS- EMC TEST FACILITY	Telocommunication	Conducted RF Susceptibility Test	ETSI EN301 489-1
514	ELECTRONICS- EMC TEST FACILITY	UPS	Conducted Emission Test (CE)	BSEN 62040-2
515	ELECTRONICS- EMC TEST FACILITY	UPS	Conducted Emission Test (CE)	BSEN 62040-2
516	ELECTRONICS- EMC TEST FACILITY	UPS	Conducted Emission Test (CE)	BS EN IEC 62040-2
517	ELECTRONICS- EMC TEST FACILITY	UPS	Conducted RF Susceptibility Test	BSEN 62040-2

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518	ELECTRONICS- EMC TEST FACILITY	UPS	Conducted RF Susceptibility Test	BS EN IEC 62040-2
519	ELECTRONICS- EMC TEST FACILITY	UPS	Electrostatic Discharge Immunity Test (ESD)	BSEN 62040-2
520	ELECTRONICS- EMC TEST FACILITY	UPS	Electrostatic Discharge Immunity Test (ESD)	BS EN IEC 62040-2
521	ELECTRONICS- EMC TEST FACILITY	UPS	Magnetic field Immunity test)	BS EN IEC 62040-2
522	ELECTRONICS- EMC TEST FACILITY	UPS	Radiated Emission Test (RE)	BS EN IEC 62040-2
523	ELECTRONICS- EMC TEST FACILITY	UPS	RF Radiated Susceptibility Test	BS EN IEC 62040-2
524	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Change of Temperature	IS 9000 : Part 14 : Sec 1 to 3
525	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Drop Test	IEC 60068-2-31
526	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Drop Test	ISO 16750-3 - Clause 4.3
527	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	QM333 (Test No 3)
528	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Steady State)	IEC 60945 (Clause 8.3)
529	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Drop Test	JSS 55555 - Test No 13
530	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Drop Test	MIL STD 810H - Method 516.8
531	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Dry Heat (High Temperature)	QM333 (Test No 2)
532	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	ISO 16750-4 (Clause 5.1.1)

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533	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Salt Spray (Corrosion)	IS 9000 (Part 11)
534	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Bump	IEC 60068-2-27
535	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Bump	IEC60255-21-2
536	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Bump	JSS 50101 (Test No 11)
537	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Bump	JSS 55555 (Test No 05)
538	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Bump	QM333 (Test No 13)
539	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Change of Temperature	ETSI-300 019- 2-3 (Clause 3)
540	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Change of Temperature	ETSI-300019- 2-2
541	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Change of Temperature	ETSI-300019- 2-4 (Clause 3)
542	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Change of Temperature	ETSI-300019-2- 1
543	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Change of Temperature	GR-63 (Clause 5.1)
544	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Change of Temperature	IEC 60068-2-14
545	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Change of Temperature	ISO 16750-4 (Clause 5.3.2)
546	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Change of Temperature	MIL STD 810H (Method 503.6)

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547	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Change of Temperature	QM333 (Test No 4)
548	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Change of Temperature	RTCA DO-160G (Section 5)
549	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Change of Temperature	SAE J1455 (Section 4.1.3.1)
550	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	"Withdrawn standard" IS 9000 : Part 2 : Sec 1 to 4
551	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	DNV 2.4 (Clause 3.9)
552	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	ETSI-300019- 2-2
553	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	ETSI-300019- 2-3 (Clause 3)
554	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	ETSI-300019-2-1
555	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	ETSI-300019-2-4 (Clause 3)
556	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	GR-63 (Clause 5.1)
557	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	IEC 60945 (Clause 8.4)
558	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	ISTA-3A
559	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	JSS 50101 (Test No 21)
560	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	JSS 55555 (Test No 18)

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561	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	MIL STD 810H (Method 502.6)
562	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	QM333 (Test No 1)
563	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	RTCA DO-160G (Section 4)
564	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	SAE J1455 (Section 4.1.3)
565	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	IEC 60068-2-1
566	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Cold (Low Temperature)	ISTA-2A
567	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Composite Temperature & Humidity	"Withdrawn" IS 9000 (Part 6)
568	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Composite Temperature & Humidity	MIL STD 810H (Method 520.4)
569	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Composite Temperature & Humidity	IEC60068-2-38
570	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Composite Temperature & Humidity	ISO 16750-4 (Clause 5.3.1)
571	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	ASTM D2247
572	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	DNV2.4 (Clause 3.8)
573	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	ETSI-300 019- 2-3 (Clause 3)
574	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	ETSI-300 019-2-2

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575	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	ETSI-300019- 2-4 (Clause 3)
576	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	ETSI-300019-2-1
577	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	IEC 60068-2-30
578	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	IEC 60945 (Clause 8.3)
579	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	IS 9000 : Part 5 : Sec 1 AND 2
580	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	ISO 16750-4 (Clause 5.6)
581	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	JSS 50101 (Test No 06)
582	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	JSS 55555 (Test No 27)
583	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	MIL STD 810H (Method 507.6)
584	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	MIL-STD-202G
585	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	RTCA DO-160G (Section 6)
586	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Cyclic)	SAE J1455 (Section 4.2)
587	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Steady State)	DNV2.4 (Clause 3.8)
588	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Steady State)	ETSI-300 019- 2-3 (Clause 3)

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589	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Steady State)	ETSI-300 019- 2-4 (Clause 3)
590	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Steady State)	ETSI-300019-2-1
591	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Steady State)	ETSI-300019-2-2
592	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Steady State)	GR-63 (Clause 5.1)
593	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Steady State)	IEC 60068-2-67
594	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Steady State)	IEC 60068-2-78
595	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Steady State)	IS 9000 : Part 4 : Second Revision
596	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Steady State)	ISO 16750-4 (Clause 5.7)
597	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Steady State)	JSS 50101 (Test No 07)
598	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Steady State)	JSS 55555 (Test No 10)
599	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Steady State)	MIL STD 810H (Method 507.6):
600	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Steady State)	MIL-STD-202G
601	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Damp Heat (Steady State)	QM333 (Test No 5)
602	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Drop Test	"Withdrawn" IEC 60068-2-32

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603	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Drop Test	ASTM D5276
604	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Drop Test	ETSI EN 300 019-2-2 - Clause 4.2 & 4.3
605	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Drop Test	GR63 - Clause 5.3
606	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Drop Test	IS 9000 : Part 7 : Sec 3 :
607	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Drop Test	ISTA -2A
608	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Drop Test	ISTA -3A
609	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Drop Test	SAE J1455- Section 4.11.3
610	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Dry Heat (High Temperature)	DNV2.4 (Clause 3.7)
611	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Dry Heat (High Temperature)	ETSI-300 019- 2-3 (Clause 3)
612	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Dry Heat (High Temperature)	ETSI-300019- 2-2
613	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Dry Heat (High Temperature)	ETSI-300019- 2-4 (Clause 3)
614	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Dry Heat (High Temperature)	ETSI-300019-2-1
615	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Dry Heat (High Temperature)	GR-63 (Clause 5.1)
616	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Dry Heat (High Temperature)	IEC 60068 2-2 (Including Amd. 1&2)

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617	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Dry Heat (High Temperature)	IEC 60945 (Clause 8.2)
618	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Dry Heat (High Temperature)	ISO 16750-4 (Clause 5.1.2)
619	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Dry Heat (High Temperature)	JSS 50101 (Test No 22)
620	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Dry Heat (High Temperature)	JSS 55555 (Test No 17)
621	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Dry Heat (High Temperature)	MIL STD 810H (Method 501.6)
622	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Dry Heat (High Temperature)	RTCA DO-160G (Section 4)
623	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Dry Heat (High Temperature)	SAE J1455 (Section 4.1.3)
624	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Dry Heat (High Temperature)	IS 9000 : Part 3 : Sec 1 to 5
625	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Dust and water	"Withdrawn Standard "ISO 20653
626	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Dust/Test Probes- IP 1X to IP 6X Degree of Protection provided by enclosures	IEC 60529:1989+AMD1:1999+AMD 2:
627	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Dust/Test probes- IP 1X to IP 6X Degree of Protection provided by enclosures	IEC 60068-2-68
628	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Low Air Pressure Altitude	GR-63 (Clause 5.1)
629	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Low Air Pressure Altitude	IS 9000 (Part 13)
630	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Low Air Pressure Altitude	JSS 50101 (Test No 02)

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631	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Low Air Pressure Altitude	JSS 55555 (Test No 03)
632	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Low Air Pressure Altitude	RTCA DO-160G (Section 4)
633	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Low Air Pressure Altitude	SAE J1455 (Section 4.9)
634	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Salt Spray (Corrosion)	ASTM B117
635	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Salt Spray (Corrosion)	DNV2.4 (Clause 3.10)
636	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Salt Spray (Corrosion)	IEC 60068-2-52
637	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Salt Spray (Corrosion)	IEC 60945 (Clause 8.12)
638	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Salt Spray (Corrosion)	ISO 16750-4 (Clause 5.5.1)
639	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Salt Spray (Corrosion)	JSS 55555 (Test No 9)
640	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Salt Spray (Corrosion)	MIL STD 810H (Method 509.6)
641	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Salt Spray (Corrosion)	NEMA -250 (Clause:5.8)
642	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Salt Spray (Corrosion)	QM333 (Test No 9)
643	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Salt Spray (Corrosion)	RTCA DO-160G (Section14)
644	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Salt Spray (Corrosion)	SAE J1455 (Section 4.3.3.1)

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645	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Salt Spray (Corrosion)	IEC 60068-2-11
646	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Shock	ETSI-300019- 2-2
647	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Shock	ETSI-300019- 2-3 (Clause 3)
648	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Shock	ETSI-300019- 2-4 (Clause 3)
649	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Shock	ETSI-300019-2-1
650	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Shock	IEC 60068-2-27
651	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Shock	IEC60255-21-2
652	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Shock	IS 9000 : Part 7 : Sec 1
653	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Shock	ISO 16750-3 (Clause 4.2)
654	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Shock	JSS 50101 (Test No 12)
655	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Shock	JSS 55555 (Test No 24)
656	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Shock	MIL STD 810H (Method 516.7)
657	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Shock	RTCA DO-160G (Section 7)
658	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Shock	SAE J1455 (Section 4.11)

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659	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic Items	Shock Test	IEC 61373
660	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Shock Test	MIL-STD-202G
661	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & electronic items	Temperature cycling	JESD22-A104F
662	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Temperature Cycling Test	MIL-HDBK-2164 A
663	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Temperature Shock / Rapid change of Temperature with Prescribed time of transfer	ISO 16750-4 (Clause 5.3.2)
664	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Temperature Shock / Rapid change of Temperature with Prescribed time of transfer	JSS 55555 (Test No 22)
665	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Temperature Shock / Rapid change of Temperature with Prescribed time of transfer	MIL STD810H (Method 503.7)
666	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Temperature Shock / Rapid change of Temperature with Prescribed time of transfer	MIL-STD-202G, Test Method 107G/Procedure:3/ Clause 3.1
667	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Temperature Shock / Rapid change of Temperature with Prescribed time of transfer	RTCA DO-160G (Section 5)
668	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Temperature Shock / Rapid change of Temperature with Prescribed time of transfer	SAE J1455 (Section 4.1.3.2)
669	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	"withdrawn standard" IS 9000 (Part 8)
670	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	DNV2.4 (Clause 3.6)
671	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	ETSI-300 019- 2-3 (Clause 3)
672	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	ETSI-300 019-2-4 (Clause 3)

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673	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	ETSI-300019-2-1
674	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	ETSI-300019-2-2-11
675	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	GR-63 (Clause 5.4)
676	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	IEC 60068-2-6
677	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	IEC 60068-2-64
678	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	IEC 60255-21-1
679	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	IEC 60945 (Clause 8.7)
680	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	ISO 16750-3 (Clause 4.1)
681	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	JSS 50101 (Test No 23,24)
682	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	JSS 55555 (Test No 28)
683	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	MIL STD 810 H (Method 514.7)
684	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	MIL-HDBK-2164 A
685	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	MIL-STD-202G
686	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	QM333 (Test No 6)

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687	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	RTCA DO-160G (Section 8)
688	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Vibration	SAE J1455 (Section 4.10)
689	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Water – IP X1 to IP X8 Degree of Protection provided by enclosures	IEC 60068-2-18
690	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Water – IP X1 to IP X8 Degree of Protection provided by enclosures	IEC 60529:1989+AMD1:1999+AMD2:
691	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical & Electronic items	Water – IP X1 to IP X8 Degree of Protection provided by enclosures	IEC 60945 (Clause 8.8)
692	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical and Electronic items	Bake Out	JESD22-A113I
693	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical and electronic items	Power and Temperature Cycling	JESD22-A105D
694	ELECTRONICS-ENVIRONMENTAL TEST FACILITY	Electrical and Electronic items	Vibration	IEC 61373
695	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	ME Equipment intended to be connected to a power source by a plug, Internal capacitive circuits	Cl. No. 8.4.3, 8.4.4 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1:
696	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device -Medical equipment & Medical Systems	Safety signs	Cl. No. 7.5 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1:
697	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Accessible parts	Cl. No. 5.9.2 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1:
698	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Accessible Parts and Applied Parts	Cl. No. 8.4.2 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1

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699	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Accompanying documents	Cl. No. 7.9 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1:
700	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Actuating parts of controls of ME Equipment	Cl. No. 15.4.6 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1:
701	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Cleaning and Disinfection of ME Equipements and ME Systems	Cl. No. 11.6.6 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
702	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Colors of the insulation of conductors	Cl. No. 7.7 (7.7.1 to 7.7.5) of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
703	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Cord anchorage	Cl. No. 8.11.3.5 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
704	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Cord guards	Cl. No. 8.11.3.6 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
705	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Creepage distances and Air Clearances	Cl. No. 8.9 (8.9.1 to 8.9.2) of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
706	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Dielectric strength	Cl. No. 8.8.3 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
707	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Distance through solid insulation or use of thin sheet material	Cl. No. 8.8.2 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
708	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Drop test	Cl. No. 15.3.4 (15.3.4.1 to 15.3.4.2) of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
709	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Durability of markings	Cl. No. 7.1.3 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1

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710	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Excessive temperatures in ME Equipment	Cl. No. 11.1 (11.1.1 to 11.1.4) of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
711	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Grips and other handling devices	Cl. No. 9.4.4 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
712	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Humidity preconditioning treatment	Cl. No. 5.7 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
713	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Impact test	Cl. No. 15.3.3 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
714	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Impedance and current-carrying capability	Cl. No. 8.6.4 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
715	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Indicator lights and controls	Cl. No. 7.8 (7.8.1, 7.8.2) of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
716	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Instability from horizontal and vertical forces	Cl. No. 9.4.2.3 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
717	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Instability in transport position	Cl. No. 9.4.2.1 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
718	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Insulating compound forming solid insulation between conductive parts & Insulating compound forming a cemented joint with other insulating parts	Cl. No. 8.9.3.2 & 8.9.3.3 of EN 60601- 1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
719	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Interruption power supply Test	Cl. No. 11.8 & 16.8 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1

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720	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Leakage Currents	Cl. No. 16.6 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
721	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Leakage Currents and Patient Auxiliary Currents	Cl. No. 8.7 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
722	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Legibility of Markings	Cl. No. 7.1.2 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
723	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Mains Parts, components and layout	Cl. No. 8.11 (8.11.1 to 8.11.3.4) of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
724	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Marking of controls and instruments	Cl. No. 7.4 (7.4.1 to 7.4.3) of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
725	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Marking on the inside of ME Equipment or ME Equipment parts	Cl. No. 7.3 (7.3.1 to 7.3.8) of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
726	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Marking on the outside of ME Equipment or ME Equipment parts	Cl. No. 7.2 (7.2.1 to 7.2.21) of EN 60601- 1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
727	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Measurement of Creepage distances and Air Clearances	Cl. No. 8.9.4 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
728	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Mechanical Hazards associated with moving parts	Cl. No. 9.2 (9.2.1 & 9.2.2) of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
729	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Mechanical strength and resistance to heat (Ball pressure test)	Cl. No. 8.8.4.1 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
730	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Mould stress relief test	Cl. No. 15.3.6 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1

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731	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Overflow in ME Equipment	Cl. No. 11.6.2 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
732	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Power input	Cl. No. 4.11 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
733	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Push test	Cl. No. 15.3.2 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
734	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Rough handling test	Cl. No. 15.3.5 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
735	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Separation of parts	Cl. No. 8.5.1 to 8.5.4 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1:
736	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Single fault conditions	Cl. No. 13.2 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
737	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Spillage on ME Equipment and ME Systems	Cl. No. 11.6.3 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
738	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Strength of Patient or Operator support or suspension systems	Cl. No. 9.8.3 (9.8.3.1 to 9.8.3.3) of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
739	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Symbols	Cl. No. 7.6 (7.6.1 to 7.6.3) of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
740	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Tensile Safety Factor	Cl. No. 9.8.2 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1
741	ELECTRONICS- MEDICAL ELECTRICAL EQUIPMENT	General medical device Medical equipment & Medical Systems-Paent Monitor ECG Monitor BP monitor Pulse Oximeter Electro cardio Graph recorder Incubator (stationory & Portable) and other small equipments	Thermal cycling	Cl. No. 8.9.3.4 of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1:

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742	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Equipment markings, instructions, and instructional safeguards	Annex F of EN 62368- 1: 2014 / IEC 62368-1:
743	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Antenna terminal insulation	Cl. No. 5.4.5 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
744	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Ball pressure test	Cl. No. 5.4.1.10.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
745	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Battery replacement test	Cl. No. 4.8.4.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
746	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Capacitor discharge after disconnection of a connector	Cl. No. 5.5.2.2 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
747	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Carts, stands, and similar carriers	Cl. No. 8.10 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
748	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Clearances & creepage distances	Cl. No. 5.4.2 & 5.4.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
749	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Compliance criteria	Cl. No. 4.8.5 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
750	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Compliance criteria (Hygroscopic materials test)	Cl. No. 5.4.1.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
751	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Compliance criteria (Insulation resistance test)	Cl. No. 5.4.10.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
752	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Cord strain relief	Annex G.7.3.2 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
753	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Crush test	Cl. No. 4.8.4.6 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
754	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Determination of working voltage	Cl. No. 5.4.1.8 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
755	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Downward force test	Cl. No. 8.6.2.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1

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756	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Drop tests	Cl. No. 4.4.3.3, 4.8.4.4, Annex T.7 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
757	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Electric strength test	Cl. No. 5.4.9 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
758	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Equipment for direct insertion into mains socket-outlets	Cl. No. 4.7 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
759	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Equipment having an electromechanical device for destruction of media	Cl. No. 8.5.4.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
760	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Equipment markings, instructions, and instructional safeguards	Annex F of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
761	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Equipment mounted to a wall, ceiling or other structure	Cl. No. 8.7 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
762	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Fixing of conductors	Cl. No. 4.6 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
763	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Handle strength	Cl. No. 8.8 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
764	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Horizontal force test and compliance criteria	Cl. No. 8.6.5 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
765	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Humidity conditioning	Cl. No. 5.4.8 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
766	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Impact tests	Cl. No. 4.4.3.4, 4.8.4.5, Annex T.6 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
767	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Impulse test	Cl. No. 5.4.10.2.2 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
768	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Input test	Annex B.2.5 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
769	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Insulation of internal wire as a part of a supplementary safeguard	Cl. No. 5.4.6 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
770	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Internal accessible safeguard tests	Cl. No. 4.4.3.5, Annex T.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
771	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Limited power source	Annex Q.1 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1

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772	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Locked-rotor overload for DC motors	Annex G.5.4.6 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
773	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Mandrel test	Cl. No. 5.4.4.6.5 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
774	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Material group and CTI	Cl. No. 5.4.3.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
775	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Maximum operating temperatures for materials, components and systems	Cl. No. 5.4.1.4, 9.2.5, Annex B.2, Annex E of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
776	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Motor overload test conditions & Running overload test and compliance criteria	Annex G.5.4.2, G.5.4.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
777	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Mounting means for slide-rail mounted equipment (SRME)	Cl. No. 8.11 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
778	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Needle flame test	Annex S.1 & S.2 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
779	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Non-detachable cord bend protection	Annex G.7.1 (G.7.5.1 & G.7.5.2) of EN 62368-1: 2014 / IEC 62368-1:
780	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Power source circuit classifications	Cl. No. 6.2.2 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
781	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Prospective touch voltage, touch current and protective conductor current	Cl. No. 5.7 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
782	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Relocation stability	Cl. No. 8.6.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
783	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Requirements for protective conductors	Cl. No. 5.6.2 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
784	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Requirements for protective earthing conductors	Cl. No. 5.6.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
785	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Resistance of the protective bonding system	Cl. No. 5.6.6 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
786	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Running overload for DC motors	Annex G.5.4.5 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1

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787	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Safeguards against fire under normal operating conditions and abnormal operating conditions	Cl. No. 6.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
788	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Safeguards against parts with sharp edges and corners	Cl. No. 8.4 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
789	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Separation between external circuits and earth	Cl. No. 5.4.11 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
790	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Simulated abnormal operating conditions	Annex B.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
791	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Simulated single fault conditions	Annex B.4 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
792	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Solid insulation	Cl. No. 5.4.4 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
793	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Static stability test	Cl. No. 8.6.2.2 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
794	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Steady force tests	Cl. No. 4.4.3.2, Annex T.2 to T.5 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
795	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Steady state test	Cl. No. 5.4.10.2.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
796	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Steady state voltage and current limits	Cl. No. 5.2.2.2 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
797	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Test for pollution degree 1 environment and for an insulating compound & Tests for semiconductor components and for cemented joints	Cl. No. 5.4.1.5.2 & 5.4.7 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
798	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Tests on coated printed boards & Coatings on component terminals	Annex G.13.6 & G.14 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
799	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Thermal cycling test procedure	Cl. No. 5.4.1.5.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
800	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Thermoplastic material tests & Stress relief test	Cl. No. 4.4.3.8, 4.8.4.2 & Annex T.8 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1

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801	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Transformers	Cl. No. 5.5.3 & G.5.3 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
802	ELECTRONICS- SAFETY TESTING FACILITY	Audio/video, information and communication technology equipment	Wheels or casters attachment requirements	Cl. No. 8.9 of BS EN 62368-1: 2014 : A11:2017 / IEC 62368-1
803	ELECTRONICS- SAFETY TESTING FACILITY	Electrical & Electronic Insulating materials	Method for the determination of the proof and the comparative tracking indices of solid insulating materials	IEC 60112 (Edition 5.0):
804	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Spillage	Cl. No. 11.3 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
805	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Cleaning	Cl. No. 11.2 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
806	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Comparative Tracking Index (CTI)	Cl. No. 6.7.1.3 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
807	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Components and subassemblies	Cl. No. 14 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010 + A1
808	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Connections to external circuits	Cl. No. .6 6of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
809	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Constructional requirements for protection against electric shock	Cl. No. 6.9 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
810	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Cord anchorage	Cl. No. 6.10.2.2 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
811	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Cord entry	Cl. No. 6.10.2.1 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
812	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Determination of accessible parts	Cl. No. 6.2 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
813	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Disconnection from supply source	Cl. No. 6.11 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
814	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Drop test	Cl. No. 8.3 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1

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815	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Durability of markings	Cl. No. 5.3 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
816	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Equipment temperature limits and resistance to heat	Cl. No. 10 (10.1 to 10.4) of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
817	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Humidity preconditioning	Cl. No. 6.8.2 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
818	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Impact test	Cl. No. 8.2.2 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
819	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Insulating material (Ball pressure test)	Cl. No. 10.5.3 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
820	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Insulation for mains circuits of overvoltage category II with a nominal supply voltage up to 300 V	Cl. No. 6.7.2 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
821	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Insulation for secondary circuits derived from mains circuits of overvoltage category II up to 300 V	Cl. No. 6.7.3 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
822	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Limit values for accessible parts	Cl. No. 6.3 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
823	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Limited-energy circuit	Cl. No. 9.4 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
824	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Mains supply	Cl. No. 5.1.3 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
825	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Marking & Warning markings	Cl. No. 5.1 & 5.2 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
826	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Non-metallic enclosures	Cl. No. 10.5.2 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
827	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Overflow	Cl. No. 11.4 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1:

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828	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Protective bonding	Cl. No. 6.5.2 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
829	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Provisions for lifting and carrying	Cl. No. 7.5 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
830	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Stability	Cl. No. 7.4 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
831	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Static test	Cl. No. 8.2.1 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
832	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Terminals for external circuits & Plugs and connectors	Cl. No. 6.6.2 & 6.10.3 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
833	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Test Procedures, The a.c voltage test & The 1 min. d.c voltage test)	Cl. No. 6.8.3.1 & 6.8.3.2 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
834	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Testing in single fault condition	Cl. No. 4.4 (4.4.1, 4.4.4) of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
835	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	The impulse voltage withstand test	Cl. No. 6.8.3.3 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
836	ELECTRONICS- SAFETY TESTING FACILITY	Electrical Equipment for Measurement, Control and Laboratory Use	Wall mounting	Cl. No. 7.6 of IEC 61010-1:2010 + A1: 2016 / BS EN 61010-1:2010+A1
837	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Abnormal operating and fault conditions	Cl. No. 5.3 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /Withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
838	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Abrasion resistance test	Cl. No. 2.10.8.4 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / WithdrawnBS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2

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839	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Access to ELV wiring	Cl. No. 2.1.1.3 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /WithdrawnBS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
840	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Access to energized parts	Cl. No. 2.1.1.1 & 2.8.2 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /WithdrawnBS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
841	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Access to hazardous voltage circuit wiring	Cl. No. 2.1.1.4 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009+A2:
842	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Adhesives for constructional purposes	Cl. No. 4.6.5 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / Withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
843	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Adjustable controls	Cl. No. 4.3.3 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /Withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
844	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Audio amplifiers in information technology equipment (Access to energized parts)	Cl. No. 2.1.1.9 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950- 1: 2005 + A1: 2009 +A2:
845	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Batteries	Cl. No. 4.3.8 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950- 1: 2005 + A1: 2009 +A2:

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846	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Clearances and creepage distances	Cl. No. 2.10.3 (2.10.3.1 to 2.10.3.9) & 2.10.4 (2.10.4.1, 2.10.4.3) of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /Withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2:
847	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Compliance criteria (Insulation resistance test)	Cl. No. 6.2.2.3 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /Withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
848	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Component external terminations & Tests on coated printed boards and coated components	Cl. No. 2.10.7 & 2.10.8 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /Withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
849	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Components	Cl. No. 1.5 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
850	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Connection by plugs and sockets	Cl. No. 4.3.5 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
851	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Construction of Printed Boards	Cl. No. 2.10.6 (2.10.6.1 to 2.10.6.4) of IS 13252 (Part 1): 2010 + A1:2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2:2013 / IEC 60950-1:2005 + A1: 2009 +A2:
852	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Cord anchorages and strain relief	Cl. No. 3.2.6 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2

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853	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Cord Guards	Cl. No. 3.2.8 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950- 1: 2005 + A1: 2009 +A2:
854	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Determination of working voltage	Cl. No. 2.10.2 (2.10.2.1 to 2.10.2.3) of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / Withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2:
855	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Direct plug-in equipment	Cl. No. 4.3.6 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /withdrawn BS EN 60950-1: 2006 + A2: 2013 /IEC 60950-1: 2005 + A1: 2009 +A2
856	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Discharge of capacitors in equipment	Cl. No. 2.1.1.7 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /Withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
857	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Disconnection from the mains supply	Cl. No. 3.4 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
858	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Drop test	Cl. No. 4.2.6 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
859	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Edges and corners	Cl. No. 4.3.1 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BSEN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
860	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Electric strength	Cl. No. 5.2 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /Withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2

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861	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Electrical insulation	Cl. No. 2.9 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
862	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Energy hazards & Energy hazards - d.c. mains supplies	Cl. No. 2.1.1.5 & 2.1.1.8 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
863	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Handles and manual controls	Cl. No. 4.3.2 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
864	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Heating elements in earthed equipment	Cl. No. 4.3.7 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
865	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Household and home/office document/media shredders (Access to hazardous moving parts)	Annex EE of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
866	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Impact test	Cl. No. 4.2.5 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
867	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Impulse test	Cl. No. 6.2.2.1 & 7.4.3 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
868	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Input current	Cl. No. 1.6.2 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2

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869	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Insulation of conductor, Termination of conductor	Cl. No. 3.1.4 & Cl.3.1.9 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950- 1: 2005 + A1: 2009 +A2:
870	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Interconnection of equipment	Cl. No. 3.5 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
871	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Limited current circuits	Cl. No. 2.4 (2.4.1 to 2.4.3) of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2:
872	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Limited power sources	Cl. No. 2.5 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
873	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Mandrel test	Cl. No. 2.10.5.8 & Annex AA of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /Withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
874	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Manual controls	Cl. No. 2.1.1.6 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /WithdrawnBS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
875	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Marking and Instructions	Cl. No. 1.7 (1.7.1 to 1.7.14) of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2:
876	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Material group and comparative tracking index	Cl. No. 2.10.4.2 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2

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877	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Materials used in high-voltage components (Needle Flame Test)	Cl. No. 4.7.3.6 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
878	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Openings in enclosures	Cl. No. 4.6 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
879	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Permanently connected equipment, Appliance inlets	Cl. No. 3.2.3 & Cl.3.2.4 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950- 1: 2005 + A1: 2009 +A2:
880	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Protection against hazardous moving parts	Cl. No. 4.4 (4.4.1 to 4.4.5) of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950- 1: 2005 + A1: 2009 +A2:
881	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Protection of equipment users from overvoltages on telecommunication networks	Cl. No. 6.2 (6.2.1, 6.2.2, 6.2.2.2, 6.2.2.2) of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950- 1: 2005 + A1: 2009 +A2:
882	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Provisions for earthing and bonding	Cl. No. 2.6 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
883	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Requirements for the mounting means of rack-mounted equipment	Annex DD of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
884	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Resistance to abnormal heat (Ball pressure test)	Cl. No. 4.5.5 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2

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885	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Resistance to fire (Glow-Wire test)	Cl. No. 4.7.3.1 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
886	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Safety interlocks	Cl. No. 2.8 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2:
887	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Securing of parts	Cl. No. 4.3.4 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
888	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	SELV circuits	Cl. No. 2.2 (2.2.1 to 2.2.4) of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2:
889	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Separation of the telecommunication network from earth	Cl. No. 6.1.2 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
890	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Solid insulation	Cl. No. 2.10.5 (2.10.5.1 to 2.10.5.14) of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2:
891	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Stability	Cl. No. 4.1 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2

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892	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Steady Force Tests	Cl. No. 4.2 (4.2.1 to 4.2.4) of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 /Withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2:
893	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Stress relief test	Cl. No. 4.2.7 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
894	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Thermal cycling	Cl. No. 2.10.9 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
895	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Thermal requirements	Cl. No. 4.5 (4.5.1 to 4.5.4) of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950- 1: 2005 + A1: 2009+A2:
896	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	TNV Circuits	Cl. No. 2.3 (2.3.1 to 2.3.5) of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2:
897	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Touch current and protective conductor current	Cl. No. 5.1 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
898	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Voltage surge test	Cl. No. 7.4.2 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2

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899	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Wall or ceiling mounted equipment	Cl. No. 4.2.10 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
900	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Wiring terminals for connection of external conductors	Cl. No. 3.3 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
901	ELECTRONICS- SAFETY TESTING FACILITY	Information Technology Equipments	Wiring, connections and supply	Cl. No. 3.0 & 3.1 of IS 13252 (Part 1): 2010 + A1: 2013 + A2: 2015 / withdrawn BS EN 60950-1: 2006 + A2: 2013 / IEC 60950-1: 2005 + A1: 2009 +A2
902	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Accessible parts	Cl. No. 5.9.2 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2:
903	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Accessible Parts and Applied Parts	Cl. No. 8.4.2 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
904	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Accompanying documents	Cl. No. 7.9 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
905	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Actuating parts of controls of ME Equipment	Cl. No. 15.4.6 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
906	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Cleaning and Disinfection of ME Equipment's and ME Systems	Cl. No. 11.6.6 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
907	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Colours of the insulation of conductors	Cl. No. 7.7 (7.7.1 to 7.7.5) of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2

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908	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Cord anchorage	Cl. No. 8.11.3.5 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
909	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Cord guards	Cl. No. 8.11.3.6 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
910	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Creepage distances and Air Clearances	Cl. No. 8.9 (8.9.1 to 8.9.2) of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
911	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Dielectric strength	Cl. No. 8.8.3 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
912	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Distance through solid insulation or use of thin sheet material	Cl. No. 8.8.2 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
913	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Drop test	Cl. No. 15.3.4 (15.3.4.1 to 15.3.4.2) of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
914	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Durability of markings	Cl. No. 7.1.3 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
915	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Excessive temperatures in ME Equipment	Cl. No. 11.1 (11.1.1 to 11.1.4) of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
916	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Grips and other handling devices	Cl. No. 9.4.4 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
917	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Humidity preconditioning treatment	Cl. No. 5.7 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2

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918	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Impact test	Cl. No. 15.3.3 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
919	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Impedance and current-carrying capability	Cl. No. 8.6.4 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
920	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Indicator lights and controls	Cl. No. 7.8 (7.8.1, 7.8.2) of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
921	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Instability excluding transport position	Cl. No. 9.4.2.2 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
922	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Instability from horizontal and vertical forces	Cl. No. 9.4.2.3 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
923	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Instability in transport position	Cl. No. 9.4.2.1 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
924	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Insulating compound forming solid insulation between conductive parts & Insulating compound forming a cemented joint with other insulating parts	Cl. No. 8.9.3.2 & 8.9.3.3 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
925	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Interruption power supply Test	Cl. No. 11.8 & 16.8 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
926	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Leakage Currents	Cl. No. 16.6 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
927	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Leakage Currents and Patient Auxiliary Currents	Cl. No. 8.7 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2

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928	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Legibility of Markings	Cl. No. 7.1.2 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
929	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Mains Parts, components and layout	Cl. No. 8.11 (8.11.1 to 8.11.3.4) of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
930	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Marking of controls and instruments	Cl. No. 7.4 (7.4.1 to 7.4.3) of EN 60601-1: 2006 + A1: 2013 / IEC 60601-1: 2005 + A1: BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
931	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Marking on the inside of ME Equipment or ME Equipment parts	Cl. No. 7.3 (7.3.1 to 7.3.8) of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
932	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Marking on the outside of ME Equipment or ME Equipment parts	Cl. No. 7.2 (7.2.1 to 7.2.21) of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
933	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	ME Equipment intended to be connected to a power source by a plug, Internal capacitive circuits	Cl. No. 8.4.3, 8.4.4 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
934	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	ME Equipment intended to be connected to a power source by a plug, Internal capacitive circuits	Cl. No. 8.4.3, 8.4.4 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
935	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Measurement of Creepage distances and Air Clearances	Cl. No. 8.9.4 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
936	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Mechanical Hazards associated with moving parts	Cl. No. 9.2 (9.2.1 & 9.2.2) of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
937	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Mechanical strength and resistance to heat (Ball pressure test)	Cl. No. 8.8.4.1 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2

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938	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Mould stress relief test	Cl. No. 15.3.6 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
939	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Overflow in ME Equipment	Cl. No. 11.6.2 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
940	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Power input	Cl. No. 4.11 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
941	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Push test	Cl. No. 15.3.2 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
942	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Rough handling test	Cl. No. 15.3.5 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
943	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Safety signs	Cl. No. 7.5 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
944	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Separation of parts	Cl. No. 8.5.1 to 8.5.4 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
945	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Single fault conditions	Cl. No. 13.2 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
946	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Spillage on ME Equipment and ME Systems	Cl. No. 11.6.3 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
947	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Strength of Patient or Operator support or suspension systems	Cl. No. 9.8.3 (9.8.3.1 to 9.8.3.3) of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2:
948	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Symbols	Cl. No. 7.6 (7.6.1 to 7.6.3) of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2

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949	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Tensile Safety Factor	Cl. No. 9.8.2 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
950	ELECTRONICS- SAFETY TESTING FACILITY	Medical Electrical Equipment and Medical Electrical Systems	Thermal cycling	Cl. No. 8.9.3.4 of BS EN 60601-1: 2006 + A2: 2021 / IEC 60601-1: 2005 + A1: 2012 + A2
951	ELECTRONICS- SAFETY TESTING FACILITY	Plastic materials / Electronic equipment / sub-assembly or component	Needle flame test	IEC 60695-11-5 (Edition 2.0)
952	ELECTRONICS- SAFETY TESTING FACILITY	Plastic materials / Electronic Equipment sub-assembly / component	Glow wire test / Glow-wire flammability test method for end-products (GWEPT) / Glow-wire flammability index (GWFI) test method for materials / Glow-wire ignition temperature (GWIT) test method for materials	IEC 60695-2-10 (Edition 3.0): 2021 / IEC 60695-2-11 (Edition 3.0): 2021 / IEC 60695-2-12 (Edition 3.0): 2021 / IEC 60695-2-13 (Edition 3)
953	ELECTRONICS- SAFETY TESTING FACILITY	Relays	AC or d.c. dielectric voltage test	Cl. No. 10.6.4.3 of IEC 60255-27 (Edition 2.0)
954	ELECTRONICS- SAFETY TESTING FACILITY	Relays	Accessible parts test	Cl. No. 10.6.2.5 of IEC 60255-27 (Edition 2.0)
955	ELECTRONICS- SAFETY TESTING FACILITY	Relays	Burden tests	Cl. No. 6.10 of IEC 60255-1 (Edition 1.0)
956	ELECTRONICS- SAFETY TESTING FACILITY	Relays	Clearances and creepage distances	Cl. No. 10.6.3 of IEC 60255-27 (Edition 2.0)
957	ELECTRONICS- SAFETY TESTING FACILITY	Relays	Contact performance (a) AC Make & Break Load. b) DC Make & Break Load. c) Short time current carrying capacity with AC & DC Load. d) Contact Continuous Current Carrying Capacity with AC & DC Load.)	Cl. No. 6.11 of IEC 60255-1 (Edition 1.0)
958	ELECTRONICS- SAFETY TESTING FACILITY	Relays	Contact-circuit resistance	Cl. No. 4.12 of IEC 61810-7 (Edition 2.0) :
959	ELECTRONICS- SAFETY TESTING FACILITY	Relays	Determination of accessible parts	Cl. No. 5.1.5.2 of IEC 60255-27 (Edition 2.0)
960	ELECTRONICS- SAFETY TESTING FACILITY	Relays	Equipment temperature limits	Cl. No. 7.3.1 of IEC 60255-27 (Edition 2.0)
961	ELECTRONICS- SAFETY TESTING FACILITY	Relays	Impulse voltage test	Cl. No. 10.6.4.2 of IEC 60255-27 (Edition 2.0)

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962	ELECTRONICS- SAFETY TESTING FACILITY	Relays	Insulation Resistance	Cl. No. 10.6.4.4 of IEC 60255-27 (Edition 2.0)
963	ELECTRONICS- SAFETY TESTING FACILITY	Relays	Insulation Resistance	Cl. No. 4.11 of IEC 61810-7 (Edition 2.0)
964	ELECTRONICS- SAFETY TESTING FACILITY	Relays	Mechanical endurance	Cl. No. 4.31 of IEC 61810-7 (Edition 2.0)
965	ELECTRONICS- SAFETY TESTING FACILITY	Relays	Operate/Pickup Voltage, Release/Reset Voltage	Cl. No. 4.13 of IEC 61810-7 (Edition 2.0)
966	ELECTRONICS- SAFETY TESTING FACILITY	Relays	Protective bonding tests	Cl. No. 10.6.4.5 of IEC 60255-27 (Edition 2.0)
967	ELECTRONICS- SAFETY TESTING FACILITY	Relays	Single-fault condition	Cl. No. 10.6.5.5 of IEC 60255-27 (Edition 2.0)
968	ELECTRONICS- SAFETY TESTING FACILITY	Relays	Timing tests (Operate & Reset Time)	Cl. No. 4.14 of IEC 61810-7 (Edition 2.0)